

18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

FCC ID: A3LSMS916U	 element	HAC (RF EMISSIONS) TEST REPORT	Approved by: Managing Director
Filename: 1M2209010097-22.A3L	Test Dates: 9/26/2022 - 11/3/2022	DUT Type: Portable Handset	Page 101 of 103

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3/29/2022

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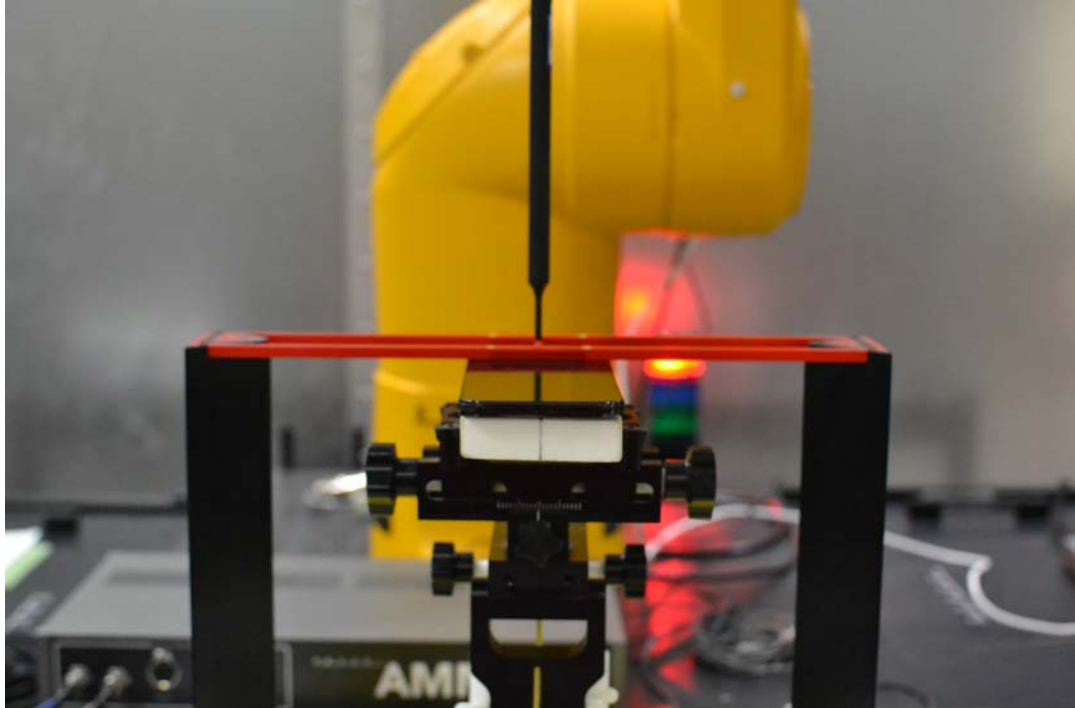


Figure 18-1
Ear Reference Point HAC Phantom Alignment

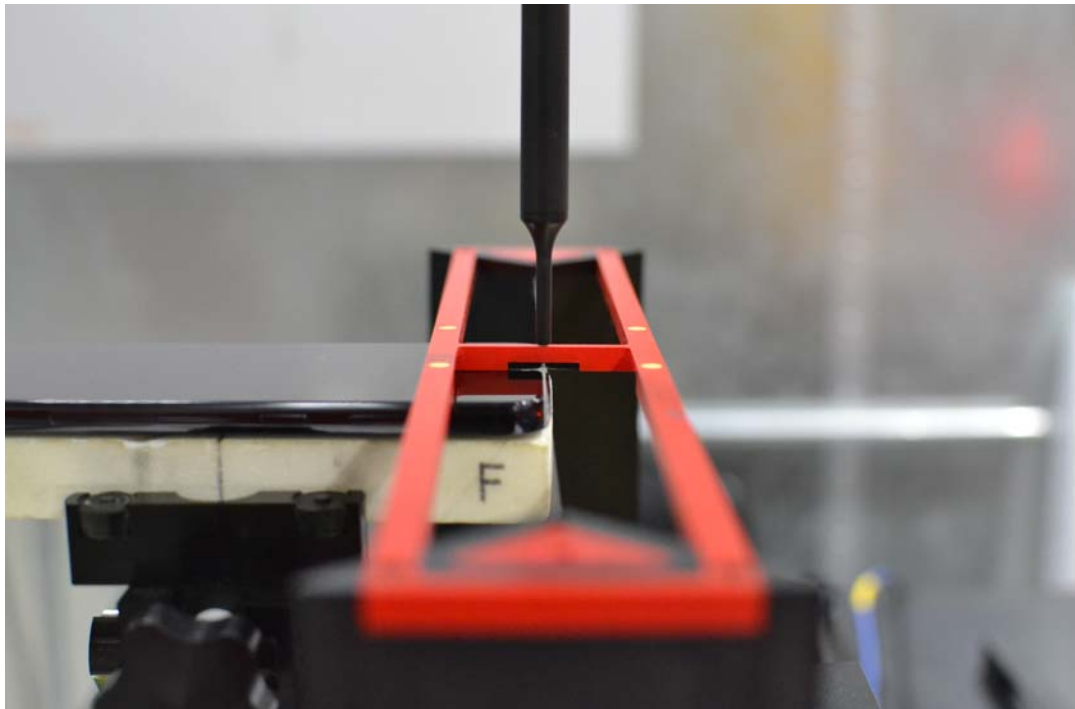


Figure 18-2
HAC Phantom Plane Alignment

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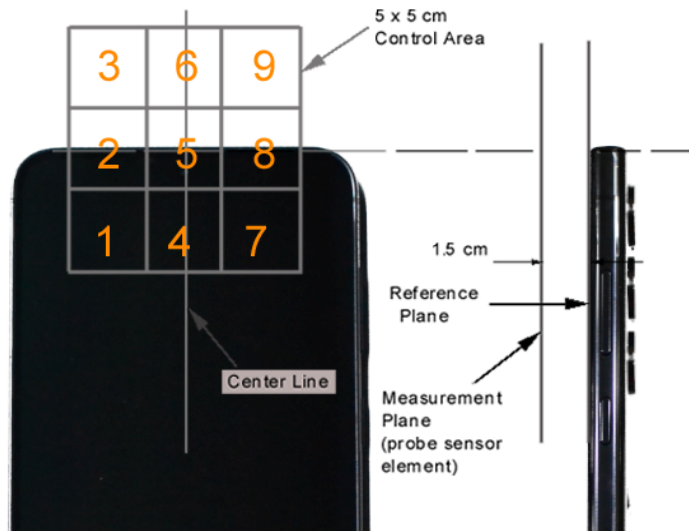


Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

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